

STF9N60M2, STFI9N60M2

N-channel 600 V, 0.72 Ω typ., 5.5 A MDmesh II Plus™ low Q_g Power MOSFETs in TO-220FP and I²PAKFP packages

Datasheet - production data

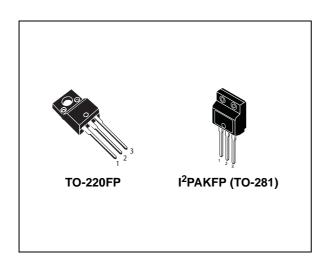
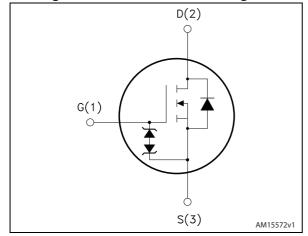


Figure 1. Internal schematic diagram



Features

Order codes	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STF9N60M2	650 V	0.78 Ω	5.5 A
STFI9N60M2	030 V	0.70 32	3.3 A

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

· Switching applications

Description

These devices are N-channel Power MOSFETs developed using a new generation of MDmeshTM technology: MDmesh II PlusTM low Q_g . These revolutionary Power MOSFETs associate a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. They are therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STF9N60M2	9N60M2	TO-220FP	Tube
STFI9N60M2	911001012	I ² PAKFP	Tube

March 2014 DocID024728 Rev 2 1/15

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Electrical characteristics (curves)	6
3	Test circuits	8
4	Package mechanical data	9
5	Revision history	12



1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
I _D	Drain current (continuous) at T _C = 25 °C	5.5 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	3.6 ⁽¹⁾	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	22 ⁽¹⁾	Α
P _{TOT}	Total dissipation at T _C = 25 °C	20	W
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T _C =25 °C)	2500	V
dv/dt (2)	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/115
T _{stg}	Storage temperature	- 55 to 150	°C
T _j	Max. operating junction temperature	150	

^{1.} Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Symbol Parameter		Unit
R _{thj-case}	Thermal resistance junction-case max	6.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	2	А
E _{AS}	Single pulse avalanche energy (starting T_j =25°C, I_D = I_{AR} ; V_{DD} =50)	105	mJ

^{2.} $I_{SD} \leq 5.5 \text{ A, di/dt} \leq 400 \text{ A/µs; V}_{DS \text{ peak}} < V_{(BR)DSS}, V_{DD} = 400 \text{ V}$

 $^{3. \}quad V_{DS} \leq \ 480 \ V$

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	600			V
1	Zero gate voltage	V _{DS} = 600 V			1	μA
I _{DSS}	drain current (V _{GS} = 0)	V _{DS} = 600 V, T _C =125 °C			100	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 3 A		0.72	0.78	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	320	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	18	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	0.68	-	pF
Coss eq. (1)	Equivalent output capacitance	V _{DS} = 0 to 480 V, V _{GS} = 0	-	88	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	6.5	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 5.5 A,	-	10	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	2	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15)	-	5.1	-	nC

Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	8.8	-	ns
t _r	Rise time	$V_{DD} = 300 \text{ V}, I_D = 3 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	7.5	-	ns
t _{d(off)}	Turn-off delay time	$ C_G = 4.7 \Omega_S, V_{GS} = 10 V$ (see <i>Figure 14</i> and <i>Figure 19</i>)	-	22	-	ns
t _f	Fall time		-	13.5	-	ns

4/15 DocID024728 Rev 2



Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		5.5	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		22	Α
V _{SD} (2)	Forward on voltage	I _{SD} = 5.5 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time		-	265		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 5.5 A, di/dt = 100 A/µs V _{DD} = 60 V (see <i>Figure 16</i>)	-	1.65		μC
I _{RRM}	Reverse recovery current	TOD = SS T (SSS Tigal's To)	-	12.5		Α
t _{rr}	Reverse recovery time	$I_{SD} = 5.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	377		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 \text{ °C}$	-	2.3		μC
I _{RRM}	Reverse recovery current	(see Figure 16)	-	12.2		Α

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration = $300 \mu s$, duty cycle 1.5%

2.1 Electrical characteristics (curves)

V_Ds(V)

Figure 2. Safe operating area

Figure 3. Thermal impedance

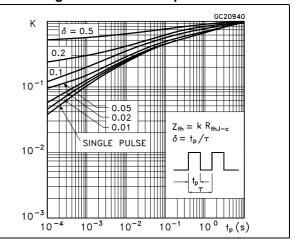
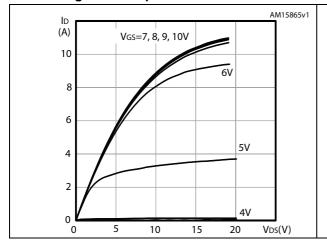


Figure 4. Output characteristics

Figure 5. Transfer characteristics



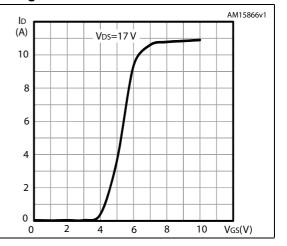
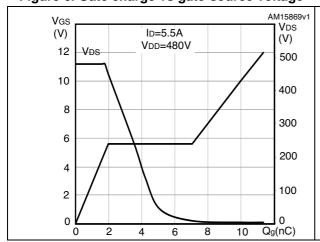
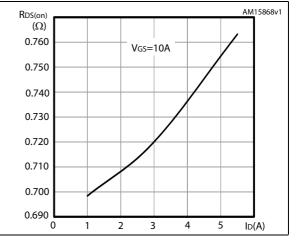


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance





DocID024728 Rev 2

6/15

Figure 8. Capacitance variations

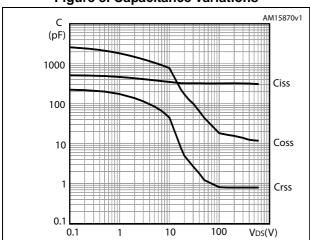


Figure 9. Output capacitance stored energy

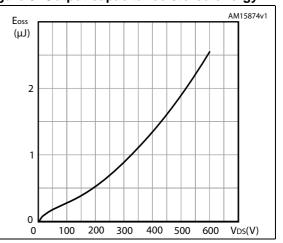
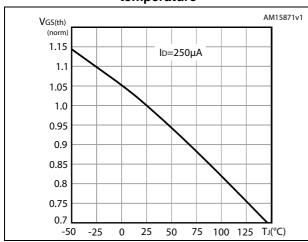


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



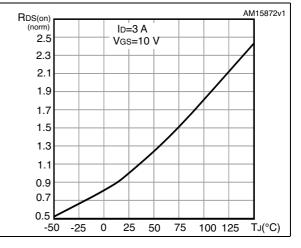
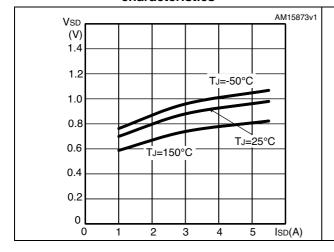
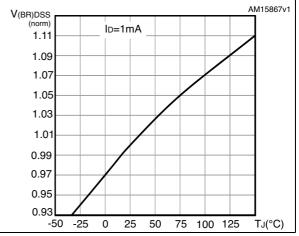


Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized $V_{(BR)DSS}$ vs temperature





57/

3 Test circuits

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

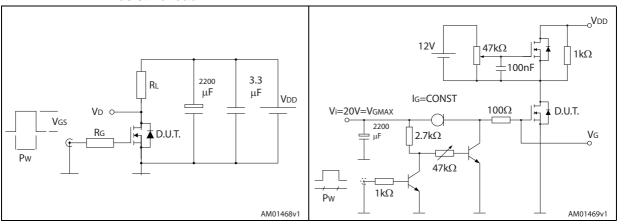


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

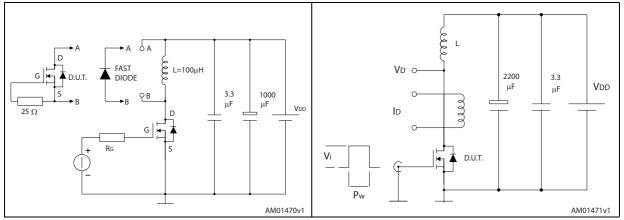
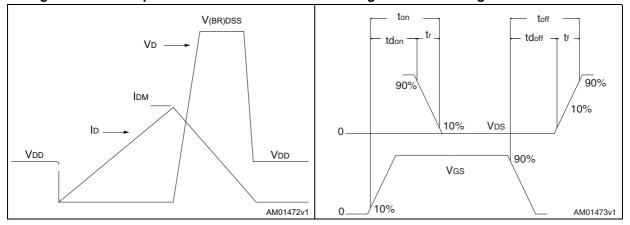


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



577

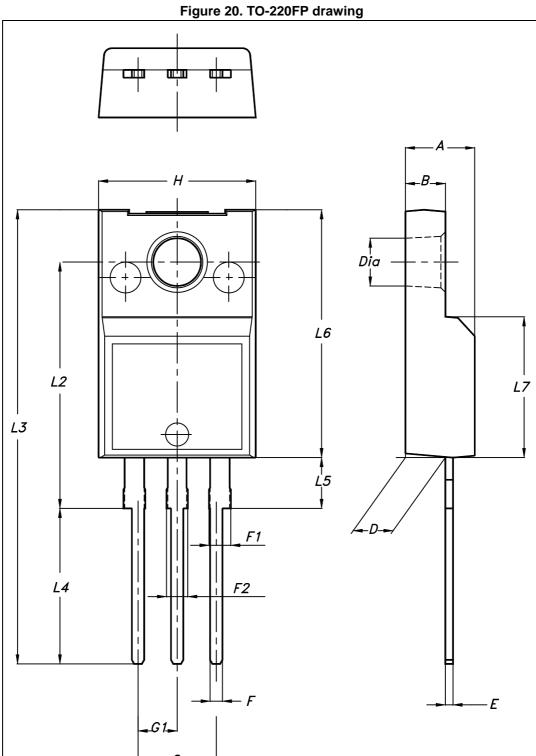
8/15

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



TO-220FP, STF9N60M2 4.1



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Table 9. TO-220FP mechanical data

	mm				
Dim.	•••	T			
	Min.	Тур.	Max.		
Α	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
E	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
Н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		



4.2 I²PAKFP (TO-281), STFI9N60M2

Figure 21. I²PAKFP (TO-281) drawing

577

Table 10. I²PAKFP (TO-281) mechanical data

Dim.		mm	
Dilli.	Min.	Тур.	Max.
А	4.40		4.60
В	2.50		2.70
D	2.50		2.75
D1	0.65		0.85
E	0.45		0.70
F	0.75		1.00
F1			1.20
G	4.95	-	5.20
Н	10.00		10.40
L1	21.00		23.00
L2	13.20		14.10
L3	10.55		10.85
L4	2.70		3.20
L5	0.85		1.25
L6	7.30		7.50



5 Revision history

Table 11. Document revision history

Date	Revision	Changes
03-Jun-2013	1	First release.The part number was previously included in datasheet DocID024399.
10-Mar-2014	2	Added: I ² PAKFP package Minor text changes

577

14/15 DocID024728 Rev 2

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